

Product Datasheet - Technical Specifications



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ME-5261 Isolated 16 bit/250 kS/s DAQ Board

- Reliable, precise measurement data acquisition.
- Potential-free, isolated, full differential channels: Ideal solution for measurement of solar cells, batteries, rechargeable batteries, fuel cells, etc.
- For PCI-Express and 3 U CompactPCI/PXI.
- 4 or 8 analog measurement inputs:
Differential, potential-free, isolated up to 500 V (for 1 s, no common GNDs).
Range ± 10.4 V. Two external digital triggers. Präzisions-A/D-Wandlung, 16 bit, 250 kS/s.
- High-precision A/D conversion, 16 bit, 250 kS/s.
Individual SAR converter per channel
- MMCX connectors (optional terminal board with BNC). Connection of probes, for example for high voltage measurements.
- 8 digital-I/O channels with variable functions:
Standard single-I/O or 4-channel frequency measurement, 4-channel frequency output.
Bitchange detection with interrupt.

| Model | Channels | Rate per channel | Resolution | Isolation | Digital-I/O | External trigger | Bus platform |
|----------------|----------|------------------|------------|--|---|--------------------------------|---------------------|
| ME-5261-8 PCIe | 8 diff. | 250 kS/s | 16 bit | yes (separate grounds/no common ground), up to 500 V | 1x 8 bit port, TTL level. standard firmware: Single digital-I/O, frequency measurement (4 of the channels, 5 MHz), frequency output (4 of the channels, 5 MHz) | 2, TTL, isolated up to 42 V | PCI-Express |
| ME-5261-8 cPCI | 8 diff. | 250 kS/s | 16 bit | yes (separate grounds/no common ground), up to 500 V | 1x 8 bit port, TTL level. standard firmware: Single digital-I/O, frequency measurement (4 of the channels, 5 MHz), frequency output (4 of the channels, 5 MHz) | 2, TTL, isolated up to 42 V | 3 HE CompactPCI/PXI |

Specification

PC Interface

| | |
|-----------------|--|
| PCI-Express-bus | 32 bit, 33 MHz, 3.3 V, PCI-Express x 1 specification version 2.0 |
| CompactPCI-bus | 32 bit, 33 MHz, 5 V, PICMG 2.0 R3.0 |
| Plug&Play | is fully supported |

Analog Inputs

| Measured Quantity/Criterion | Condition/Explanation | Value |
|---------------------------------|-----------------------------|---|
| Number of channels | subdevice 0 (streaming) | 4 or 8 analog inputs |
| Operation modes | single | reading/writing triggered by software or externally |
| | stream timer | timer-controlled reading/writing of the values via FIFO |
| | stream trigger sample | trigger-controlled reading/writing of the values via FIFO |
| | interrupt | bit-pattern change, bit-pattern compare |
| FIFO size | FIFO_IN | 8192 Values |
| Transfer rate in streaming mode | between the ME-5200 and PC | max. 25 MHz (cPCI) or 30 MHz (PCIe) (system-dependent)* |
| Measured Quantity/Criterion | Condition/Explanation | Value |
| Timer (CHAN time)* | ME-5265 (2.0 MS/s) | 500 ns...65 s (33..FFFFFFFFHex Ticks) |
| | ME-5284 (1.6 MS/s) | 621 ns...65 s (41..FFFFFFFFHex Ticks) |
| | ME-5283, ME-5263 (1.0 MS/s) | 1 μ s...65 s (66..FFFFFFFFHex Ticks) |

| | | |
|------------------------------------|------------------------------|--|
| | ME-5282, ME-5262 (500 kS/s) | 2 μ s...65 s (132..FFFFFFFFHex Ticks) |
| | ME-5281, ME-5261 (250 kS/s) | 4 μ s...65 s (264..FFFFFFFFHex Ticks) |
| Timer resolution | programmable | 15.15 ns (1 Tick) |
| External trigger inputs | for the analog input section | TRIG_A1, TRIG_A2 |
| External trigger edges | | rising, falling, any |
| Sampling rate max. | ME-5284 (synchronous) | 1.6 MS/s, 18 bit |
| | ME-5283 (synchronous) | 1.0 MS/s, 18 bit |
| | ME-5282 (synchronous) | 500 kS/s, 18 bit |
| | ME-5281 (synchronous) | 250 kS/s, 18 bit |
| | ME-5265 (synchronous) | 2.0 MS/s, 16 bit |
| | ME-5263 (synchronous) | 1.0 MS/s, 16 bit |
| | ME-5262 (synchronous) | 500 kS/s, 16 bit |
| | ME-5261 (synchronous) | 250 kS/s, 16 bit |
| Resolution | ME-528x, option S, T, F | 18 bit (79.3 μ V) |
| | ME-528x, option E | 18 bit (793 μ V) |
| | ME-526x, option S, T | 16 bit (317 μ V) |
| | ME-526x, option E | 16 bit (3174 μ V) |
| Input voltage range | option S | ± 10.4 V |
| | option T | ± 10.4 V ²⁾ |
| | option E | ± 104 V |
| | option F | ± 10.4 V |
| Measured Quantity/Criterion | Condition/Explanation | Value |
| Max. input voltage | option S | ± 20 V |
| | option T | ± 13 V |
| | option E | ± 160 V |
| | option F | ± 20 V |
| Input impedance | option S | $R_i > 100$ M Ω , $C_i = 5$ pF |
| | option T | $R_i = 1$ M Ω , $C_i = 15$ pF |
| | option E | $R_i = 200$ k Ω , $C_i = 2$ pF |

| | | |
|--------------------------------|--|---|
| | option F | $R_i > 100 \text{ M}\Omega$, $C_i = 100 \text{ pF}$ |
| Input current | option S | 40 nA |
| | option T | 10 μA |
| | option E | 500 μA |
| | option F | 40 nA |
| Bandwidth (3 dB) | option S (500kS/s. 2,0 MS/s) | 920 kHz |
| | option T (500kS/s. 2,0 MS/s) | 750 kHz ³⁾ |
| | option E (500kS/s. 2.0 MS/s) | 750 kHz |
| | option F (500kS/s. 1.6 MS/s) | 700 kHz |
| | option S, T, E (250 kS/s) | 700 kHz |
| Bandwidth (0.1 dB flatness) | option S (500 kS/s. 2.0MS/s) | 130 kHz |
| | option T (500 kS/s. 2.0 MS/s) | 100 kHz ³⁾ |
| | option E (500 kS/s. 2.0 MS/s) | 100 kHz |
| | option F (500 kS/s. 1.6 MS/s) | 80 kHz |
| | option S, T, E (250 kS/s) | 80 kHz |
| SNR at 1 MS/s and 10 kS | option S, T, E (18 bit, 1.6MS/s) | 103.6 dB _{FS, RMS} |
| | option F (18 bit, 1.6 MS/s) | 105.5 dB _{FS, RMS} |
| | option S, T, E F (16 bit, 250 kS/s. 2.0 MS/s) | 90 dB _{FS, RMS} |
| Coupling capacitance | | 23 nF |
| Isolation voltage | channel to channel, channel to PC ground | max. 300 VDC |
| Reference ground | fully differential channels | not required |

¹⁾Signal-to-noise ratio (SNR) indicates the ratio between the signal and noise levels of the individual channels. Measured with the 18-bit version, a sampling rate of 1 MS/s and using 10 kS.

²⁾The measuring range depends on the probe in use: „x1“: $\pm 10.4 \text{ V}$, „x10“: $\pm 104 \text{ V}$, „x100“: $\pm 1040 \text{ V}$.

³⁾with „x10“-sampling probe.

Digital Trigger Inputs for the A/D Section

| Measured Quantity/Criterion | Condition/Explanation | Value |
|-----------------------------|---|---------------------------------|
| Number | | 2 (TRIG_A1, TRIG_A2) |
| Max. trigger rate | applies to successive pulses of one of the two trigger inputs | max. sampling rate of the board |
| Max. input level | | -0,5.. +5.5 V |
| Input level U_{IL} | | max. 0.8 V |
| U_{IH} | | min. 2 V |
| Input current I_{IN} | | $\pm 10 \mu\text{A}$ |
| Delay time | | max. 30 ns |
| Isolation voltage | signal to GND_PC and GND_TRIG to GND_PC | max. 42 V |
| Reference ground | | GND_TRIG |

Digital Input/Output

| Measured Quantity/Criterion | Condition/Explanation | Value |
|-----------------------------|-------------------------------|--|
| Port | subdevice 1 | 8-bit bidirectional |
| Operation modes | single | software triggered reading/writing |
| | interrupt | monitoring the digital ports for a change in the bit-pattern or for a bit-pattern comparison |
| Input/output rate | (depends on the system) | software controlled |
| Max. input level | | -0.5.. +7.0 V |
| Input level U_{IL} | | max. 0.8 V |
| U_{IH} | | min. 2 V |
| Input current I_{IN} | | $\pm 10 \mu\text{A}$ |
| Output level U_{OL} | At $I_{OUT} = 12 \text{ mA}$ | max. 0.4 V |
| U_{OH} | At $I_{OUT} = -12 \text{ mA}$ | min. 2.8 V |
| Output current I_{OUT} | per pin | $\pm 12 \text{ mA}$ |
| Reference ground | | PC ground (GND_PC) |

Frequency Input/Output

| | |
|--------------|--|
| Availability | alternative subdevice configuration via ME-iDC |
| Signal form | rectangular |

Frequency Measuring Channels

| Measured Quantity/Criterion | Condition/Explanation | Value |
|-----------------------------|---|--|
| Reference ground | | PC ground (GND_PC) |
| Number of channels | (FI_0...3) | 4 inputs (TTL) |
| Input level | see digital I/O | |
| Input current | see digital I/O | |
| Period (T) | $T_{\min.} = T_{\min. \text{ asym.}} = T_{\min \text{ sym.}}$ $T_{\max. \text{ asym.}} \quad T_{\max. \text{ sym.}}$ | 181.81 ns (5.5 MHz) 32.5 s (0.03 Hz) 65 s (0.015 Hz) |
| Duty cycle | variable, depending on T | measurable in steps of 1 tick |
| Resolution | 1 Tick | 15.15 ns |
| Accuracy | | 15.15 ns |
| Operation modes | | Single |

Pulse Generator Channel

| Measured Quantity/Criterion | Condition/Explanation | Value |
|-----------------------------|---|--|
| Reference ground | | PC ground (GND_PC) |
| Number of channels | (FO_0...3) | 4 outputs (TTL) |
| Output level | see digital I/O | |
| Period (T) | $T_{\min.} = T_{\min. \text{ asym.}} = T_{\min. \text{ sym.}}$ $T_{\max. \text{ asym.}}$ $T_{\max. \text{ sym.}}$ | 181.81 ns (5.5 MHz) 32.5 s (0.03 Hz) 65 s (0.015 Hz) |
| Duty cycle | variable depending on T | adjustable in steps of 1 tick |
| Resolution | 1 tick | 15.15 ns |
| Accuracy | | ± 15.15 ns |
| Operation modes | | single |

Interrupt

| Measured Quantity/Criterion | Condition/ Explanation | value |
|-----------------------------|---------------------------|---|
| Interrupt sources | passed directly to the PC | bit-pattern change, bit-pattern compare |

General Data

| Measured Quantity/Criterion | Condition/ Explanation | Value |
|-----------------------------|----------------------------------|--|
| Power supply | CompactPCI | +5 V (via PCI-bus) |
| | PCI-Express | +3.3 V (via PCIe-bus), +5 V (via Molex-plug from PC power-supply-unit) |
| Current consumption | CompactPCI (idling current) | 3.3 V : 240 mA, 5 V : 570 mA |
| | CompactPCI (8 AI, 8 DIO 1MS/s) | 3.3 V : 650 mA, 5 V : 1.8 A |
| | PCI-Express (idling current) | 3,3 V : 370 mA, 5 V : 570 mA |
| | PCI-Express (8 AI, 8 DIO, 1MS/s) | 3,3 V : 770 mA, 5 V : 1,8 A |
| Board dimensions | CompactPCI | 3U CompactPCI boards |
| | PCI-Express | 162 mm x 98 mm |
| Connections | ST1..4 or ST1..8 | 4 or 8 MMCX coaxial sockets |
| | ST9 | HDMI connector, type HEC |
| Operating temperature | | 0...70 °C |
| Storage temperature | | -40...100 °C |
| Air humidity | | 20...55 % (non-condensing) |

| | |
|---------------|----|
| Certification | CE |
|---------------|----|

Pinout

Note: „ME-5200“ stands for all the models in the ME-5200 series.

Legend for pinouts:

| Pin-name | Function |
|------------|---|
| AI_0..7+ | positive signal of the analog input channels (subdevice 0) |
| AI_0..7- | negative signal of the analog input channels (subdevice 0) |
| DIO_0..7 | digital input/output (subdevice 1) |
| FI_0..3 | frequency measurement inputs (subdevice 1, alternative configuration) |
| FO_0..3 | pulse generator outputs (subdevice 1, alternative configuration) |
| TRIG_A1 | first digital trigger input for AI section (referenced to GND_TRIG) |
| TRIG_A2 | second digital trigger input for AI section (referenced to GND_TRIG) |
| GND_TRIG | isolated ground for TRIG_A1 and TRIG_A2 |
| GND_PC | PC ground |
| „reserved“ | pins reserved for extensions |

These pins must not be connected, otherwise the board can be irreversibly damaged!



Note: the level of the unused pins DIO_4..7 in the “Frequency measurement” (FI) and “Pulse generator” (FO) configurations. **These pins are connected to ground!**

HDMI Connector (Digital I/O)

HDMI connector type HEC for digital I/Os (opt. FI/FO) and digital trigger inputs.

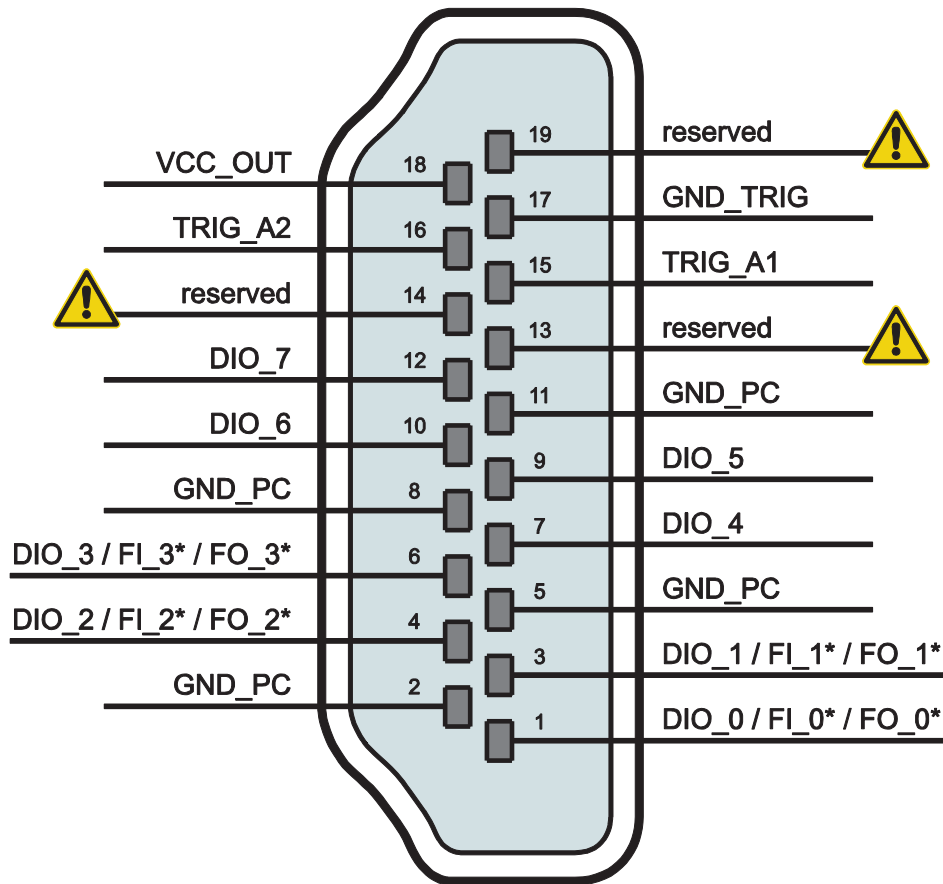


Diagram 23: HDMI connector of the ME-5200 series (ST9)

*It is only possible to use these pins as frequency measuring inputs (FI_x) or as pulse generator outputs (FO_x) after the relevant subdevice has been appropriately configured with the ME-iDC. The other pins of the relevant digital port can then no longer be used for digital input/output.



Reserved pins must not be connected, otherwise the board may be irreversibly damaged.

Mounting bracket with analog inputs

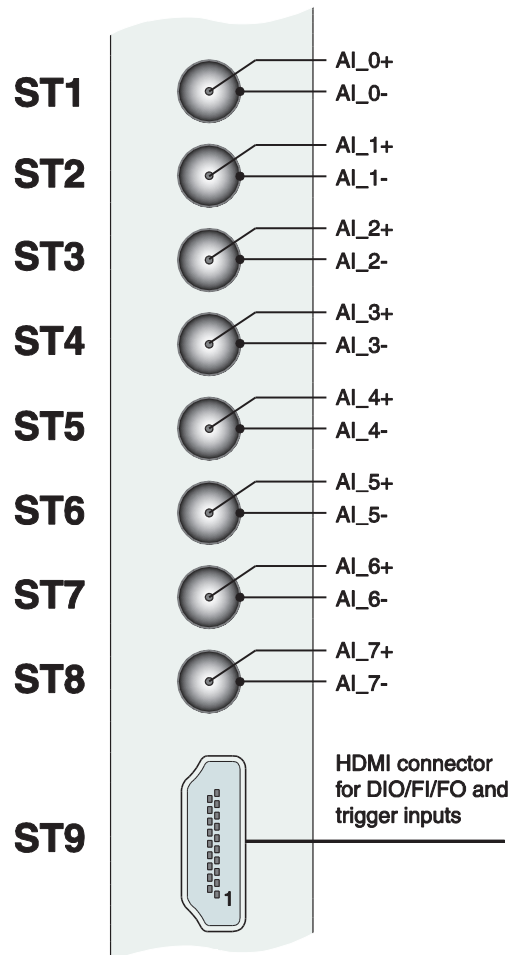


Diagram 24: Slot bracket of the ME-5200 series

Note: ST1..8 are MMCX coaxial-sockets. The number of analog inputs depends on the model.

Terminal block for the ME-5200

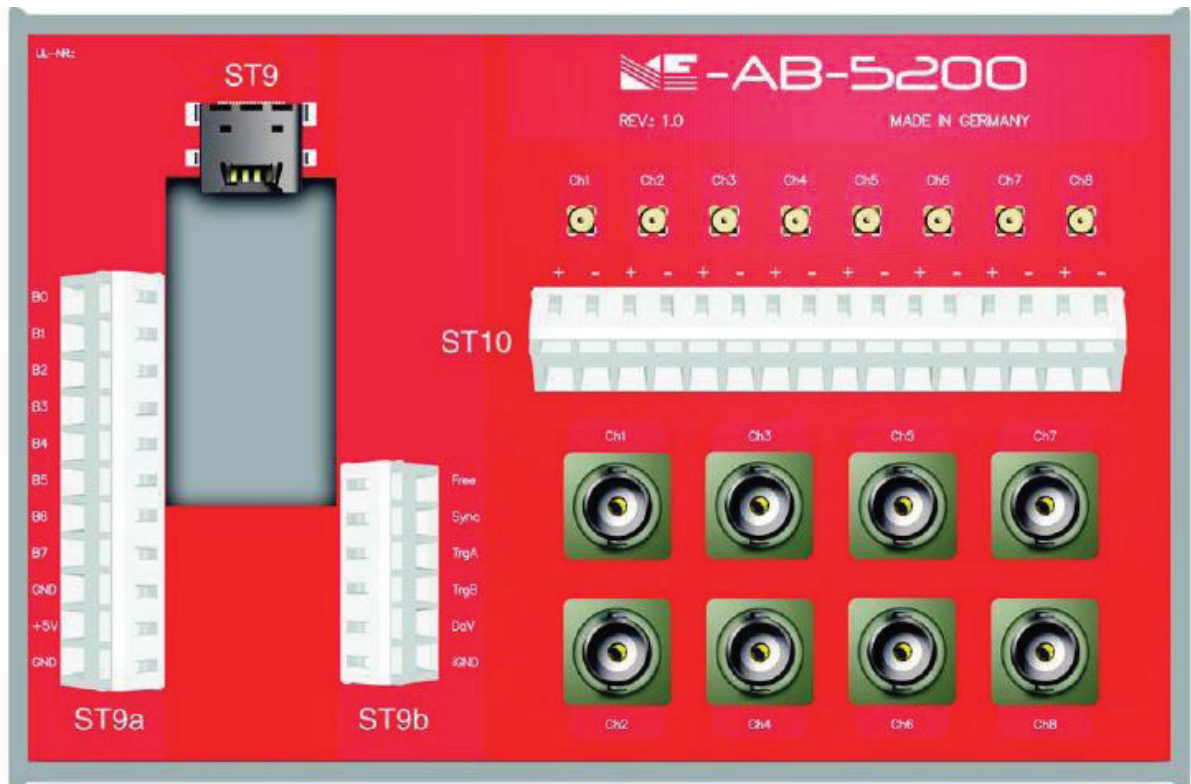


Diagram 25: ME-AB-5200

Signal assignments

| Signal Name (manual) | Label on Terminal Block | Signal Name (manual) | Label on Terminal Block |
|----------------------|-------------------------|----------------------|-------------------------|
| AI_0+/- | Ch1 | DIO_0..7 | B0..7 |
| AI_1+/- | Ch2 | reserved* | Free |
| AI_2+/- | Ch3 | reserved* | Sync |
| AI_3+/- | Ch4 | TRIG_A1 | TrgA |
| AI_4+/- | Ch5 | TRIG_A2 | TrgB |
| AI_5+/- | Ch6 | reserved* | DaV |
| AI_6+/- | Ch7 | GND_TRIG | iGND |
| AI_7+/- | Ch8 | GND_PC | GND |
| | AI_0+/- | VCC_OUT | +5 V |

Table 6: ME-AB-5200 signal assignments